## Notice of References Cited

Application/Control No.	Applicant(s)/Pater	nt Under
10/632,089	Reexamination TIRKKONEN ET	AL.
Examiner	Art Unit	
DUC M. NGUYEN	2618	Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,075,821	06-2000	Kao et al.	375/260
*	В	US-7,133,459	11-2006	Onggosanusi et al.	375/267
*	O	US-7,110,378	09-2006	Onggosanusi et al.	370/334
*	D	US-7,460,876	12-2008	Sadri et al.	455/522
*	Е	US-6,085,106	07-2000	Sendonaris et al.	455/522
*	F	US-6,292,515	09-2001	Kao et al.	375/260
*	O	US-2004/0001552	01-2004	Koifman, Gil	375/260
*	Н	US-2005/0180354	08-2005	Cho et al.	370/328
*	_	US-2008/0192683	08-2008	Han et al.	370/329
	7	US-			
	К	US-			
	L	US-			
	м	US-			

## FOREIGN PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS						
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## NON DATENT DOCUMENTS

NON-PATENT DOCUMENTS		
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	×	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.